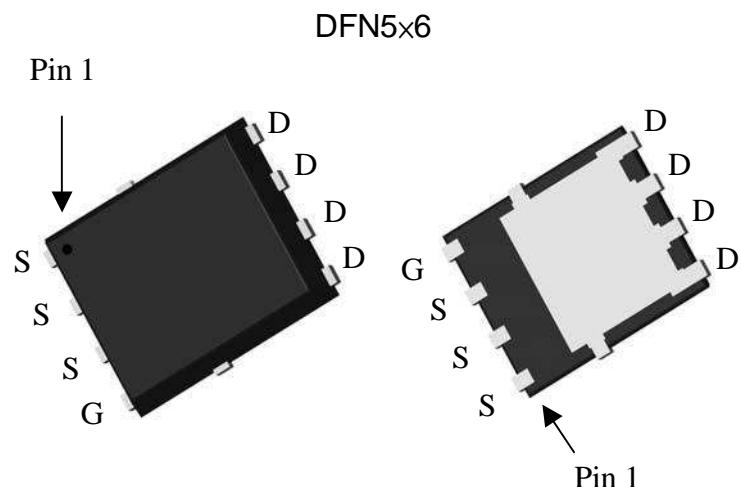


N-Channel Enhancement Mode Power MOSFET

Features:

- Single Drive Requirement
- Low On-resistance
- Fast Switching Characteristic
- Repetitive Avalanche Rated
- Pb-free lead plating and Halogen-free package

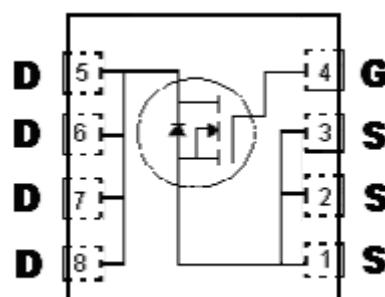
Outline



BV _{DSS}	100V
I _D @V _{GS} =10V, T _C =25°C	45A
I _D @V _{GS} =10V, T _A =25°C	15A
R _{DSON} (TYP)	V _{GS} =10V, I _D =11.5A
	V _{GS} =4.5V, I _D =9.5A
	9.2mΩ
	12.8mΩ

Symbol

KWD011N10RH8



G : Gate D : Drain S : Source

Ordering Information

Device	Package	Shipping
KWD011N10RH8	DFN 5x6 (Pb-free lead plating and halogen-free package)	3000 pcs / tape & reel



Absolute Maximum Ratings ($T_a=25^\circ C$)

Parameter	Symbol	10s	Steady State	Unit
Drain-Source Voltage	V_{DS}	100		V
Gate-Source Voltage	V_{GS}	± 20		
Continuous Drain Current @ $T_c=25^\circ C$, $V_{GS}=10V$ (Note 1)	I_D	45		A
Continuous Drain Current @ $T_c=100^\circ C$, $V_{GS}=10V$ (Note 1)		28		
Continuous Drain Current @ $T_a=25^\circ C$, $V_{GS}=10V$ (Note 2)	I_{DSM}	15	10	
Continuous Drain Current @ $T_a=70^\circ C$, $V_{GS}=10V$ (Note 2)		12	8	
Continuous Drain Current @ $T_a=85^\circ C$, $V_{GS}=10V$ (Note 2)		10.8	7.2	
Pulsed Drain Current (Note 3)	I_{DM}	180 *1		
Avalanche Current (Note 3)	I_{AS}	40		
Avalanche Energy @ $L=0.5mH$, $I_D=33A$, $V_{DD}=50V$ (Note 2, 4)	E_{AS}	272		mJ
Repetitive Avalanche Energy @ $L=0.05mH$ (Note 3)	E_{AR}	5 *2		
Total Power Dissipation	$T_c=25^\circ C$ (Note 1)	P_D	50	W
	$T_c=100^\circ C$ (Note 1)		20	
	$T_a=25^\circ C$ (Note 2)	P_{DSM}	5.7	
	$T_a=70^\circ C$ (Note 2)		4.0	
	$T_a=85^\circ C$ (Note 2)		3.6	
Operating Junction and Storage Temperature Range	T_j, T_{stg}	-55~+150		°C

Thermal Data

Parameter	Symbol	Typical	Maximum	Unit
Thermal Resistance, Junction-to-ambient (Note 2)	$R_{\theta JA}$	18	22	°C/W
		42	50	
Thermal Resistance, Junction-to-case	$R_{\theta JC}$	2.2	2.5	

- Note : 1.The power dissipation P_D is based on $T_{j(MAX)}=150^\circ C$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
 2.The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2 oz. copper, in a still air environment with $T_a=25^\circ C$. The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
 3.Repetitive rating, pulse width limited by junction temperature $T_{j(MAX)}=150^\circ C$. Ratings are based on low frequency and low duty cycles to keep initial $T_j=25^\circ C$.
 4.100% tested by conditions of $L=0.5mH$, $I_{AS}=20A$, $V_{GS}=10V$, $V_{DD}=50V$

Characteristics (Tc=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BVDSS	100	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	1.3	-	2.7		V _{DS} = V _{GS} , I _D =250μA
G _{FS} *1	-	30	-	S	V _{DS} =10V, I _D =20A
I _{GSS}	-	-	±100	nA	V _{GS} =±20V
IDSS	-	-	1	μA	V _{DS} =80V, V _{GS} =0V
	-	-	25		V _{DS} =80V, V _{GS} =0V, T _j =125°C
R _{DSON} *1	-	9.2	12	mΩ	V _{GS} =10V, I _D =11.5A
	-	12.8	17		V _{GS} =4.5V, I _D =9.5A
Dynamic					
C _{iss}	-	2841	-	pF	V _{GS} =0V, V _{DS} =25V, f=1MHz
C _{oss}	-	313	-		
C _{rss}	-	33	-		
Q _g *1, 2	-	54	-	nC	V _{DS} =50V, V _{GS} =10V, I _D =11.5A
Q _{gs} *1, 2	-	11	-		
Q _{gd} *1, 2	-	12	-		
t _{d(ON)} *1, 2	-	21	-	ns	V _{DS} =50V, I _D =11.5A, V _{GS} =10V, R _{GS} =3Ω
t _r *1, 2	-	18.6	-		
t _{d(OFF)} *1, 2	-	56	-		
t _f *1, 2	-	7	-		
R _g	-	2.4	-	Ω	f=1MHz
Source-Drain Diode					
I _S *1	-	-	45	A	
I _{SM} *3	-	-	180		
V _{SD} *1	-	0.82	1.2	V	I _S =15A, V _{GS} =0V
trr	-	39	-	ns	I _F =22A, dI _F /dt=100A/μs
Qrr	-	69	-		

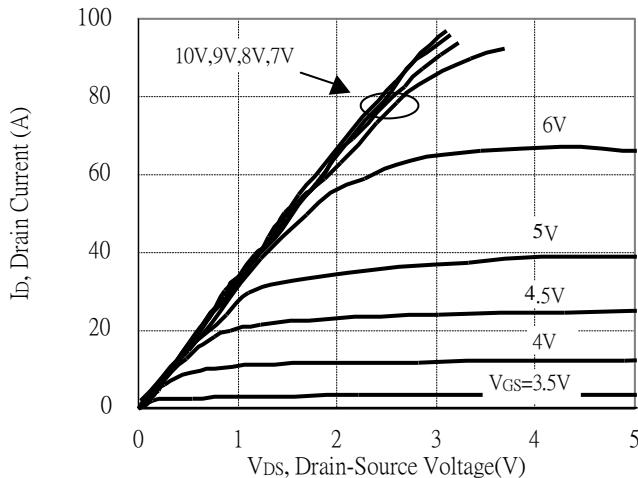
Note : *1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

*2.Independent of operating temperature

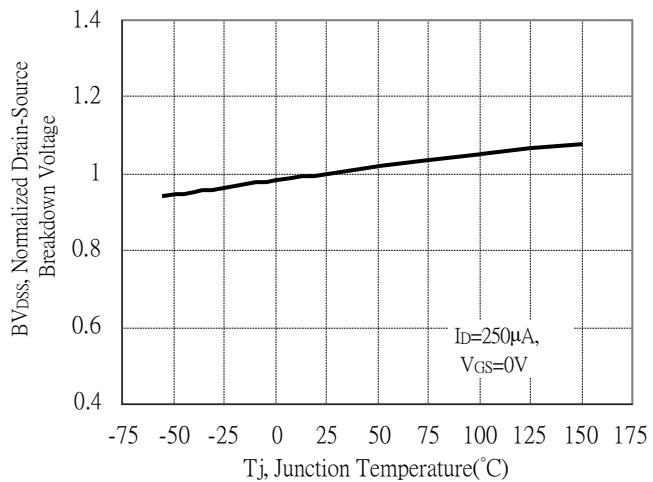
*3.Pulse width limited by maximum junction temperature.

Typical Characteristics

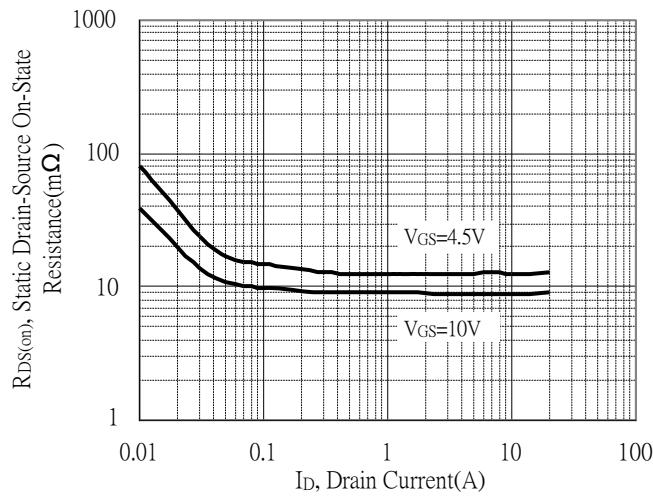
Typical Output Characteristics



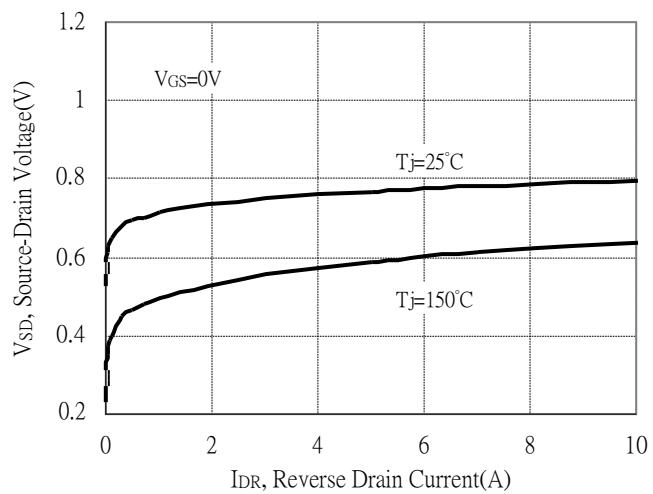
Breakdown Voltage vs Ambient Temperature



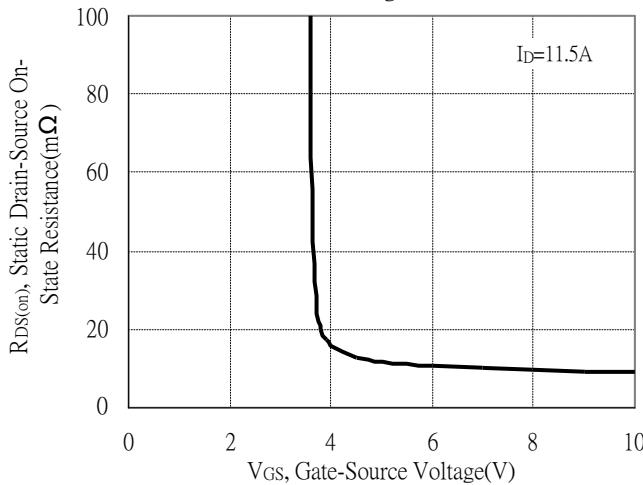
Static Drain-Source On-State resistance vs Drain Current



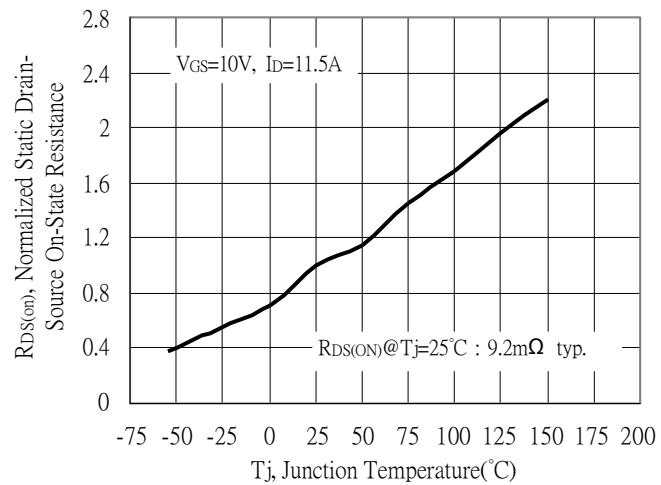
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

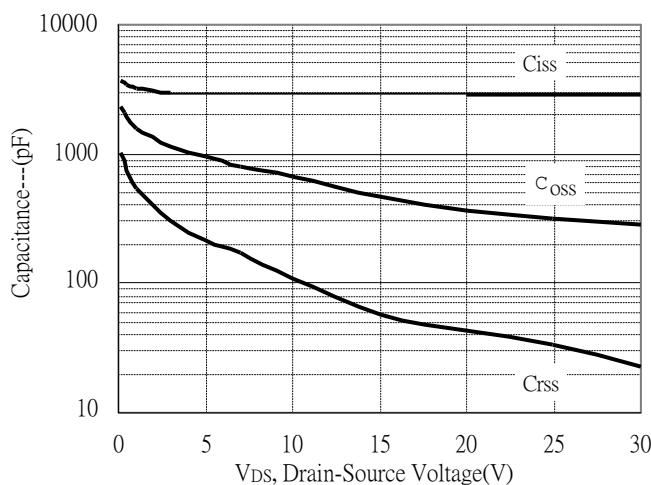


Drain-Source On-State Resistance vs Junction Temperature

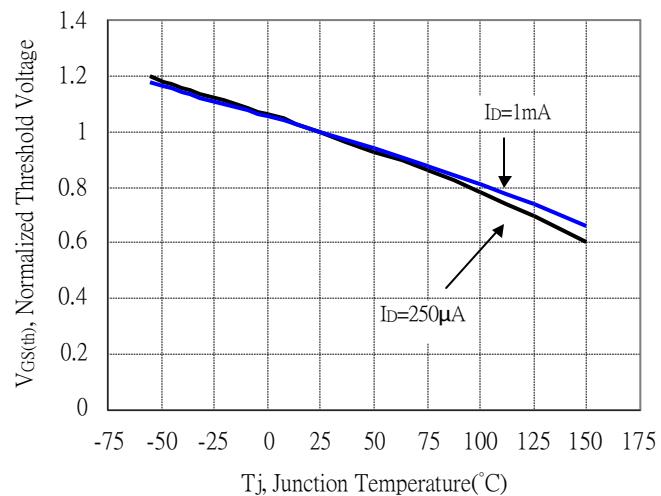


Typical Characteristics(Cont.)

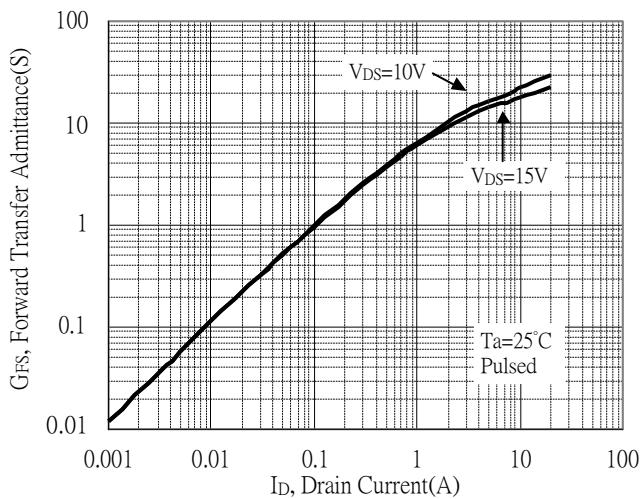
Capacitance vs Drain-to-Source Voltage



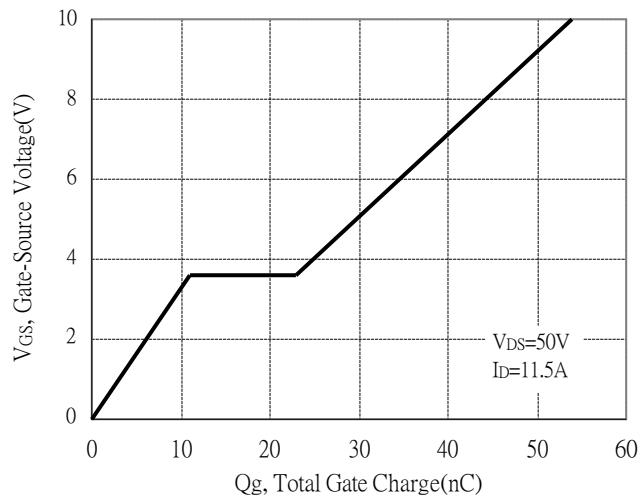
Threshold Voltage vs Junction Temperature



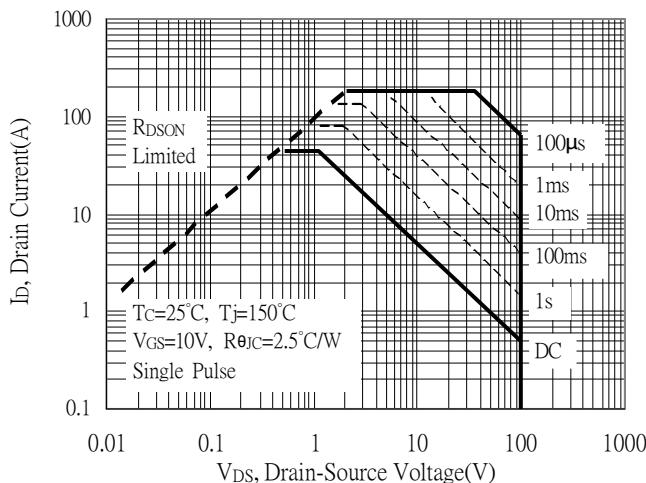
Forward Transfer Admittance vs Drain Current



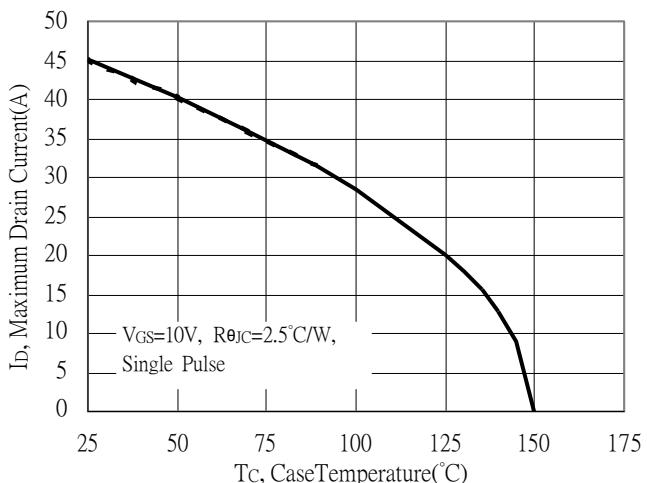
Gate Charge Characteristics



Maximum Safe Operating Area

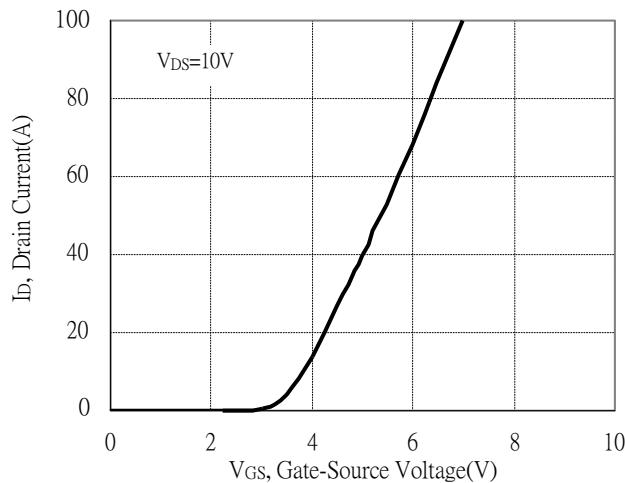


Maximum Drain Current vs CaseTemperature

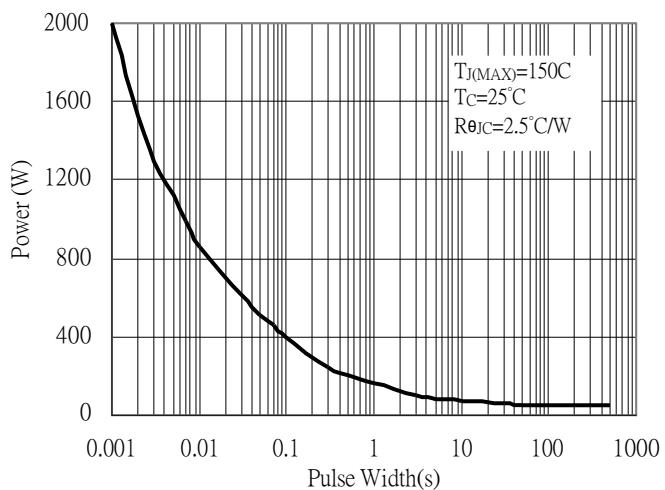


Typical Characteristics(Cont.)

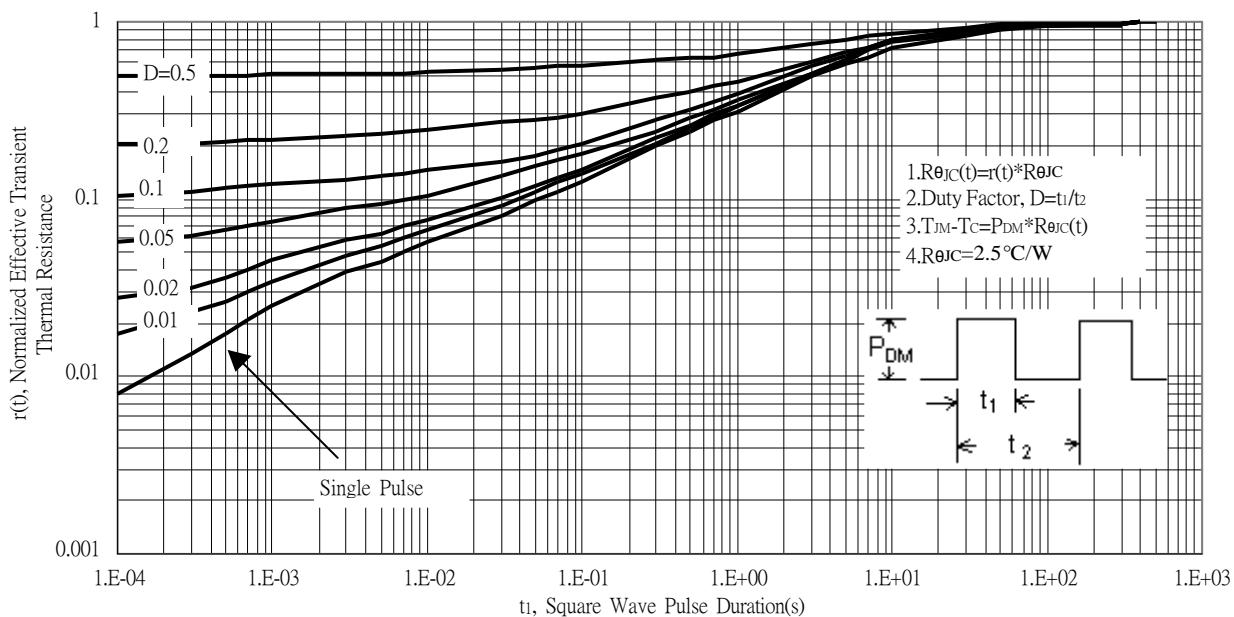
Typical Transfer Characteristics



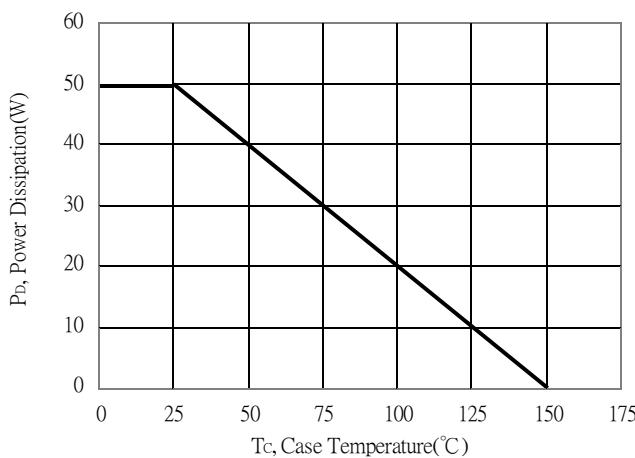
Single Pulse Maximum Power Dissipation



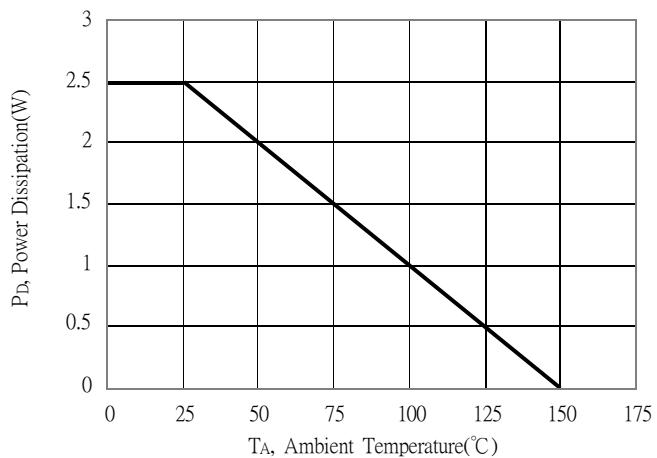
Transient Thermal Response Curves



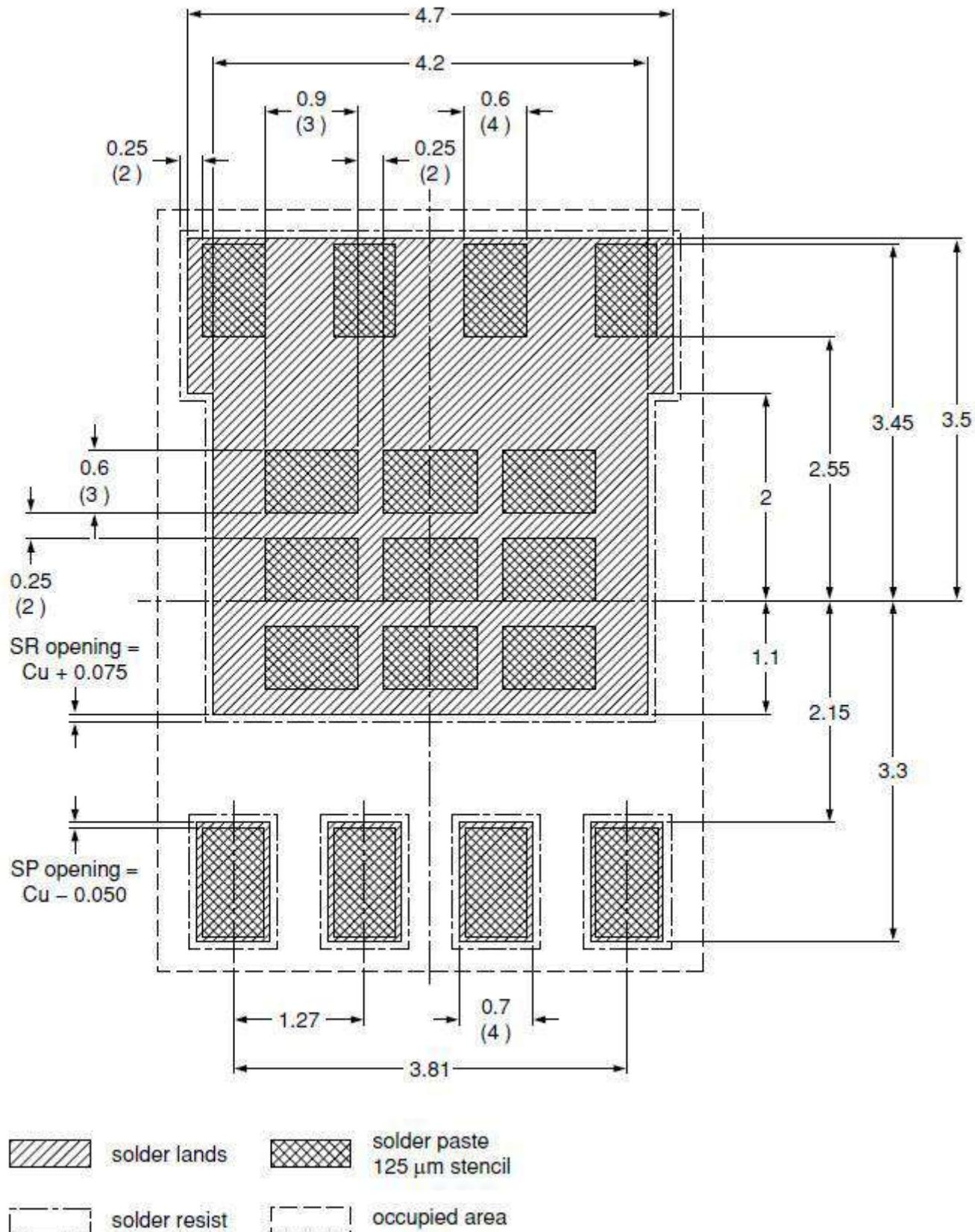
Power Derating Curve



Power Derating Curve

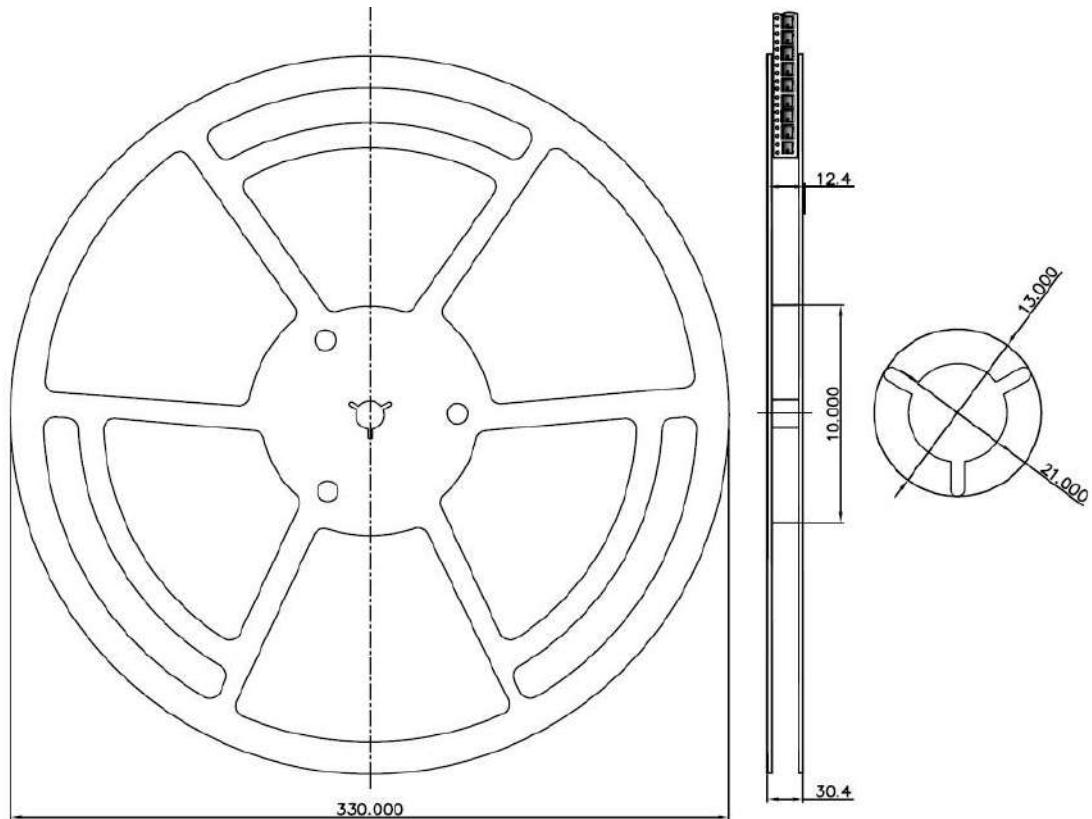


Recommended Soldering Footprint & Stencil Design

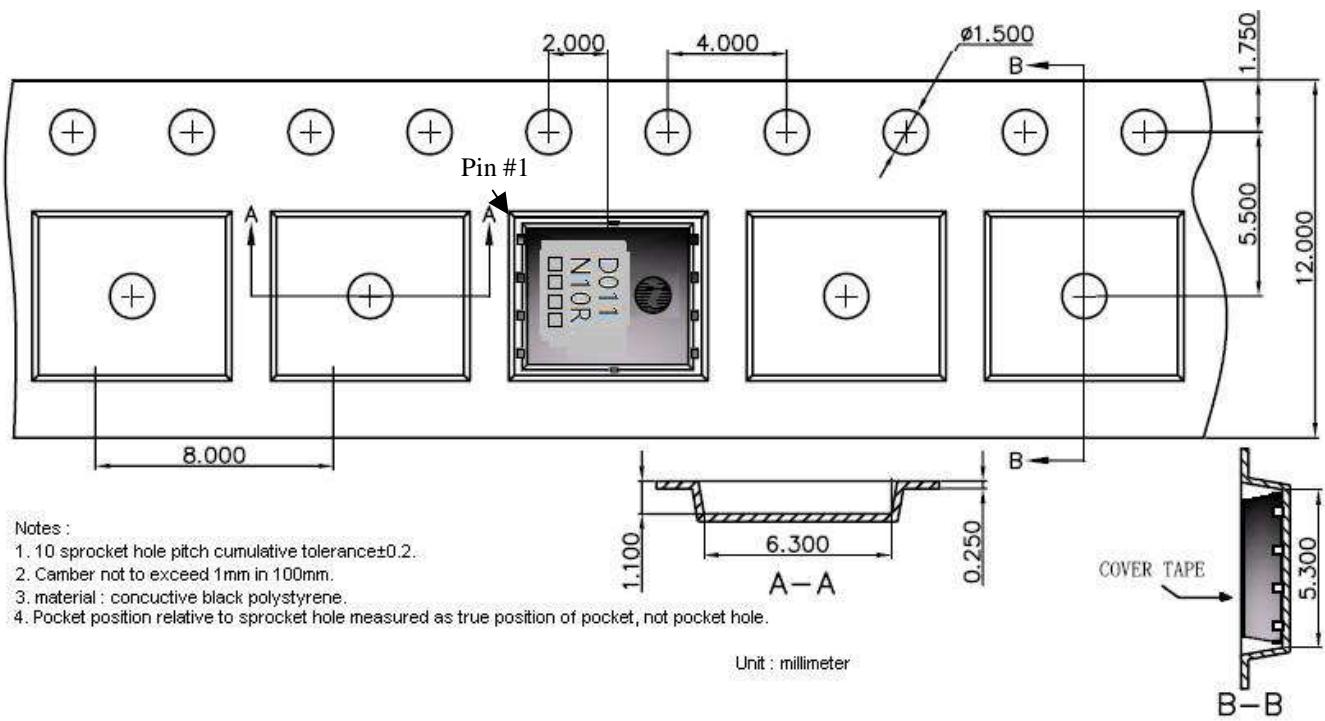


unit : mm

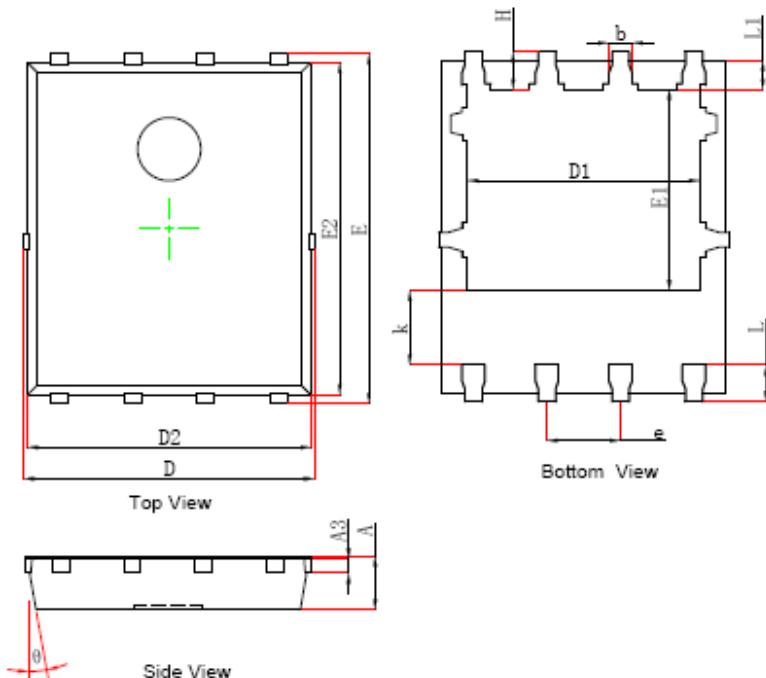
Reel Dimension



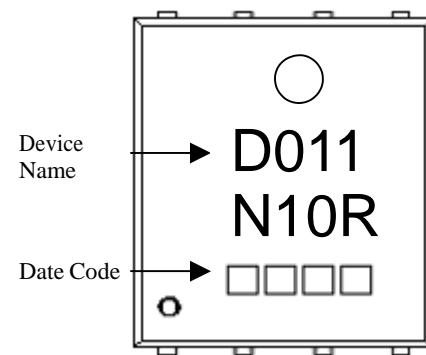
Carrier Tape Dimension



DFN5x6 Dimension



Marking :



8-Lead DFN5x6 Plastic Package
 Package Code : H8

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.900	1.000	0.035	0.039	k	1.190	1.390	0.047	0.055
A3	0.254	REF	0.010	REF	b	0.350	0.450	0.014	0.018
D	4.944	5.096	0.195	0.201	e	1.270	TYP.	0.050	TYP.
E	5.974	6.126	0.235	0.241	L	0.559	0.711	0.022	0.028
D1	3.910	4.110	0.154	0.162	L1	0.424	0.576	0.017	0.023
E1	3.375	3.575	0.133	0.141	H	0.574	0.726	0.023	0.029
D2	4.824	4.976	0.190	0.196	θ	10°	12°	10°	12°
E2	5.674	5.826	0.223	0.229					